

RoHS Compliant Product  
A suffix of "-C" specifies halogen and lead-free

## FEATURES

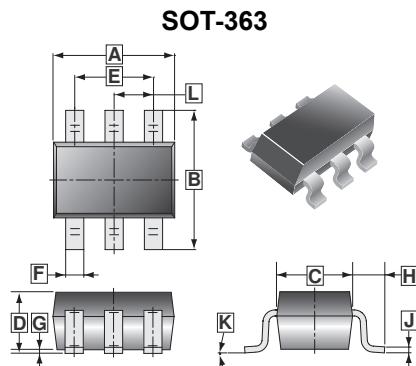
- 20V/760mA
- $R_{DS(ON)} \leq 450\text{m}\Omega @ V_{GS}=4.5\text{V}$
- $R_{DS(ON)} \leq 650\text{m}\Omega @ V_{GS}=2.5\text{V}$
- $R_{DS(ON)} \leq 1300\text{m}\Omega @ V_{GS}=1.8\text{V}$
- Reliable and Rugged
- Green Device Available
- ESD Protection

## MARKING

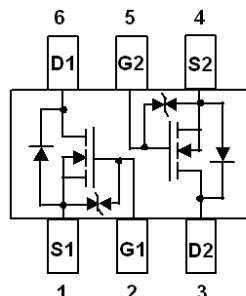
20K

## PACKAGE INFORMATION

Package	MPQ	Leader Size
SOT-363	3K	7 inch



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	1.80	2.20	G	0.100	REF.
B	1.80	2.45	H	0.525	REF.
C	1.15	1.35	J	0.08	0.25
D	0.80	1.10	K	8°	
E	1.10	1.50	L	0.650 TYP.	
F	0.10	0.35			



## ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub>=25°C unless otherwise specified)

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V <sub>DS</sub>	20	V
Gate-Source Voltage	V <sub>GS</sub>	±12	V
Continuous Drain Current @V <sub>GS</sub> =4.5V <sup>1</sup>	I <sub>D</sub>	0.76	A
T <sub>A</sub> =85°C		0.55	
Pulsed Drain Current <sup>3</sup>	I <sub>DM</sub>	3	A
Power Dissipation	P <sub>D</sub>	300	mW
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	150, -55~150	°C
Thermal Data			
Maximum Junction to Ambient <sup>1</sup>	R <sub>θJA</sub>	417	°C / W
Maximum Junction to Ambient <sup>2</sup>		625	°C / W
Maximum Junction to Case	R <sub>θJC</sub>	300	°C / W

**ELECTRICAL CHARACTERISTICS** ( $T_J=25^\circ\text{C}$  unless otherwise specified)

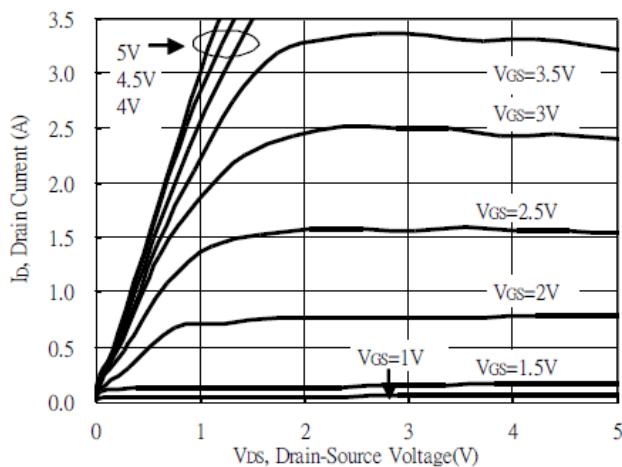
Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	20	-	-	V	$I_D=250\mu\text{A}$ , $V_{GS}=0$
Gate-Threshold Voltage	$V_{GS(\text{th})}$	0.45	-	1.2	V	$V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$
Gate-Source Leakage Current	$I_{GSS}$	-	-	$\pm 10$	$\mu\text{A}$	$V_{GS}=\pm 10\text{V}$
Drain-Source Leakage Current	$I_{DSs}$	-	-	1	$\mu\text{A}$	$V_{DS}=20\text{V}$ , $V_{GS}=0$ , $T_J=25^\circ\text{C}$
Drain-Source Leakage Current	$I_{DSs}$			10	$\mu\text{A}$	$V_{DS}=16\text{V}$ , $V_{GS}=0$ , $T_J=70^\circ\text{C}$
Drain-Source On-Resistance <sup>4</sup>	$R_{DS(\text{ON})}$	-	-	450	$\text{m}\Omega$	$V_{GS}=4.5\text{V}$ , $I_D=600\text{mA}$
		-	-	650		$V_{GS}=2.5\text{V}$ , $I_D=400\text{mA}$
		-	-	1300		$V_{GS}=1.8\text{V}$ , $I_D=350\text{mA}$
Total Gate Charge	$Q_g$	-	1.3	-	nC	$I_{DS}=0.6\text{A}$ , $V_{DS}=16\text{V}$ , $V_{GS}=4.5\text{V}$
Gate-Source Charge	$Q_{gs}$	-	0.3	-		
Gate-Drain ("Miller") Charge	$Q_{gd}$	-	0.5	-		
Turn-on Delay Time	$T_{d(\text{on})}$	-	4	-		
Rise Time	$T_r$	-	10	-	nS	$V_{DD}=10\text{V}$ , $V_{GS}=10\text{V}$ , $I_{DS}=0.6\text{A}$ , $R_{\text{GEN}}=3.3\Omega$
Turn-off Delay Time	$T_{d(\text{off})}$	-	15	-		
Fall Time	$T_f$	-	2	-		
Input Capacitance	$C_{iss}$	-	60	-	pF	$V_{DS}=10\text{V}$ , $V_{GS}=0$ , $f=1\text{MHz}$
Output Capacitance	$C_{oss}$	-	14	-		
Reverse Transfer Capacitance	$C_{rss}$	-	9	-		
<b>Source-Drain Diode</b>						
Continuous Source Current <sup>1</sup>	$I_s$	-	-	0.76	A	
Pulsed Source Current <sup>3</sup>	$I_{sm}$	-	-	3	A	
Diode Forward Voltage <sup>4</sup>	$V_{SD}$	-	-	1.2	V	
Reverse Recovery Time	$t_{rr}$	-	4.9	-	nS	$I_F=0.5\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$ , $T_J=25^\circ\text{C}$
Reverse Recovery Charge	$Q_{rr}$	-	1.0	-	nC	

Notes:

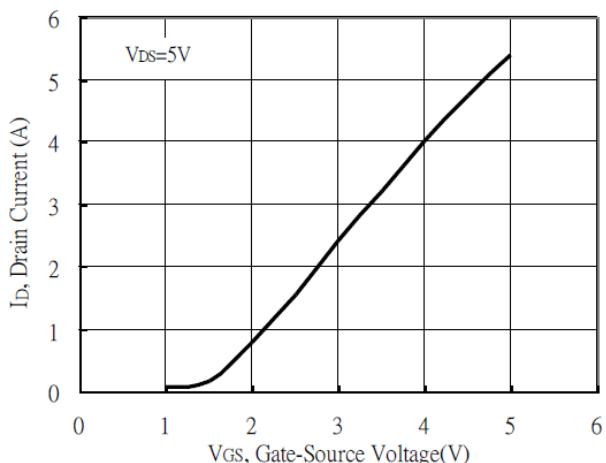
1. Surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper,  $t \leq 10 \text{ sec}$
2. Surface mounted on FR4 board
3. Pulse width limited by maximum junction temperature,  $P_w \leq 300\mu\text{s}$ , Duty cycle  $\leq 1\%$
4. The data tested by pulsed , pulse width  $\leq 300\mu\text{s}$  , duty cycle  $\leq 2\%$

## CHARACTERISTIC CURVES

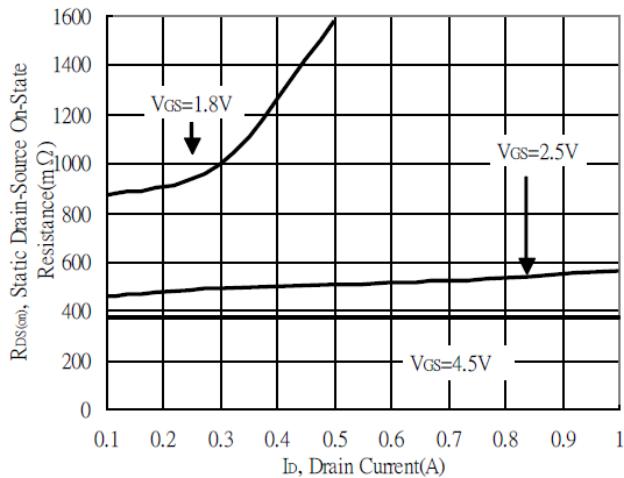
Typical Output Characteristics



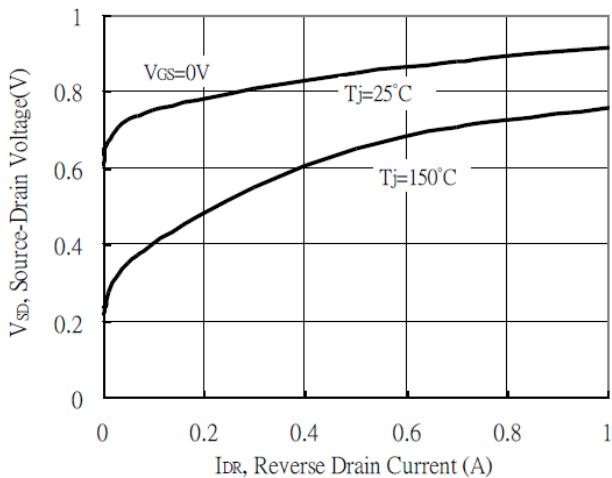
Typical Transfer Characteristics



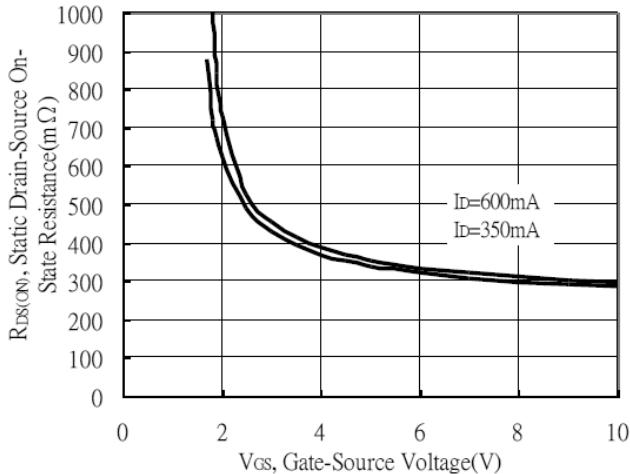
Static Drain-Source On-State resistance vs Drain Current



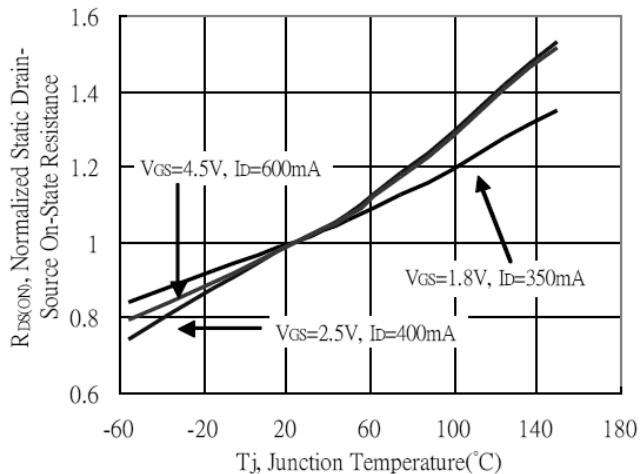
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

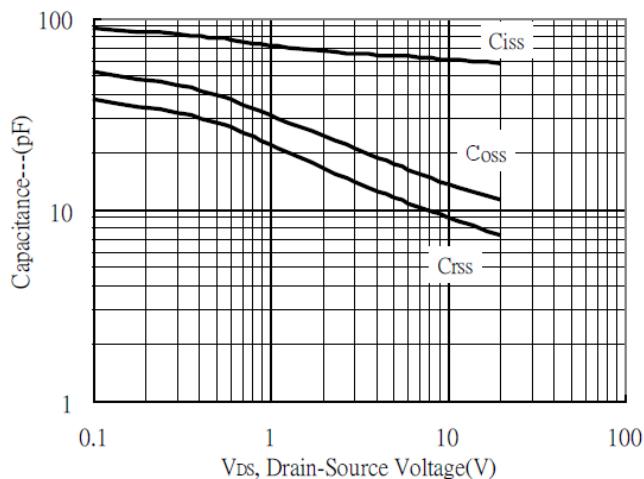


Drain-Source On-State Resistance vs Junction Temperature

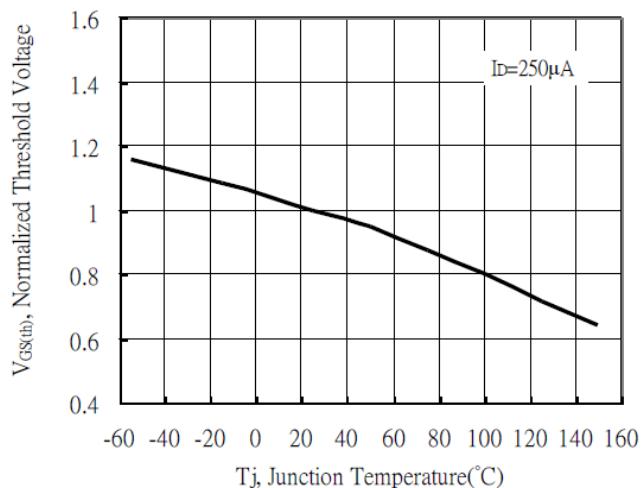


## CHARACTERISTIC CURVES

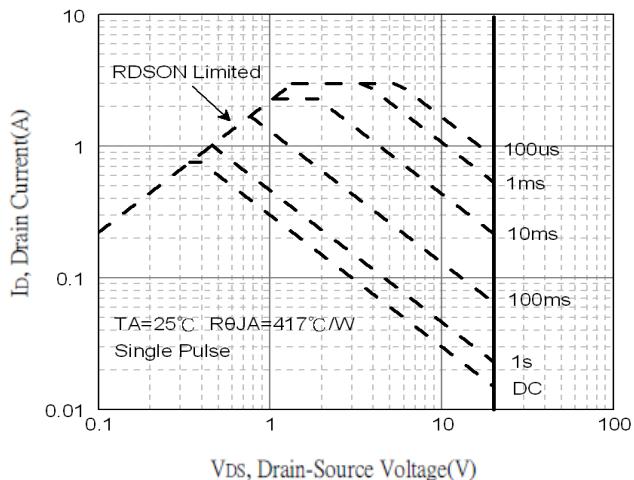
Capacitance vs Drain-to-Source Voltage



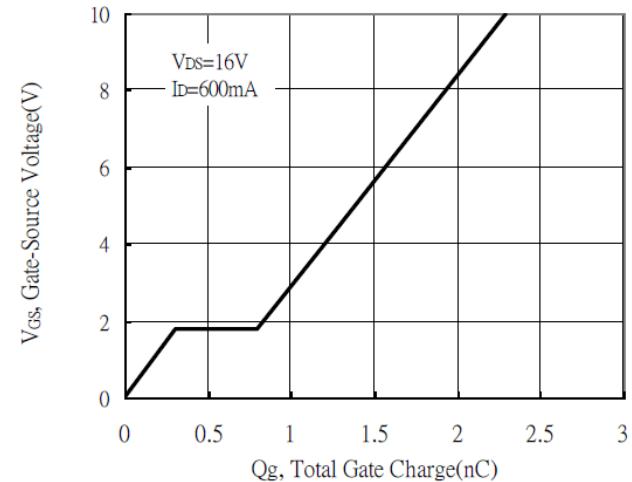
Threshold Voltage vs Junction Temperature



Maximum Safe Operating Area



Gate Charge Characteristics



Transient Thermal Response Curves

